![intersil logo]

# Micro Power Programmable Voltage Reference

## FEATURES

- **1.25V 1.0%, 20ppm/°C Tempco Reference**
- **Adjustable to ±0.25% Over the 0 to 1.25V Range**
- **8 bit, 100kΩ XDCP on-chip**
- **Programmable Resolution of 4.9mV (255 steps)**
- **Extra Matched 100kΩ Resistor Available for Increased Resolution Over a Smaller Range**
- **2.7V to 5.5V Supply Range**
- **2-Wire Interface for Programming Reference Setting**
- **Low Supply Current: 12µA in Normal Mode**
- **8-pin TSSOP Package**
- **Programmable Reference**
- **NV Memory**
- **Pb-Free Plus Anneal Available (RoHS Compliant)**

## PROGRAMMABLE VOLTAGE REFERENCE APPLICATIONS

- **Sensor Bias**
- **Variable DAC reference**
- **Linear Voltage Regulators**
- **DC/DC converters**
- **Voltage comparators**
- **Motor controllers**
- **Amplifier biasing**

## DESCRIPTION

The Intersil X60250 combines a temperature compensated voltage reference with a Intersil Digitally Controlled Potentiometer (XDCP) to provide a precision adjustable reference with a range of 0.0V to 1.25V. The device includes a serial bus interface to enable in-circuit programming of the reference voltage.

The XDCP contains a resistor chain with 255 taps to provide 8 bits of digital adjustment to the reference voltage. Non-volatile storage retains the digital wiper setting, for permanent reference programming. An additional matched 100kΩ resistor is available to increase resolution of the output voltage while retaining accuracy.

## IC BLOCK DIAGRAM
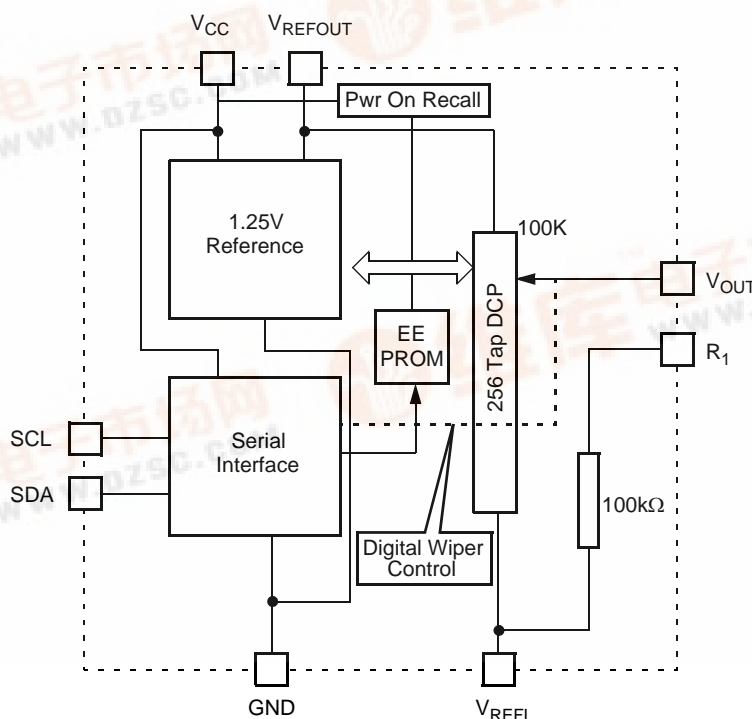
## *Ordering Information*

| PART NUMBER | PART MARKING | OUTPUT VOLTAGE (V) | RESOLUTION | TEMP RANGE (°C) | PACKAGE |
|---|---|---|---|---|---|
| X60250V8I | 60250 I | 1.250 | 8 bits | -40 to 85 | 8 Ld TSSOP |
| X60250V8IZ (Note) | 60250I Z | 1.250 | 8 bits | -40 to 85 | 8 Ld TSSOP (Pb-free) |

NOTE: Intersil Pb-free plus anneal products employ special Pb-free material sets; molding compounds/die attach materials and 100% matte tin plate termination finish, which are RoHS compliant and compatible with both SnPb and Pb-free soldering operations. Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

## PIN CONFIGURATION
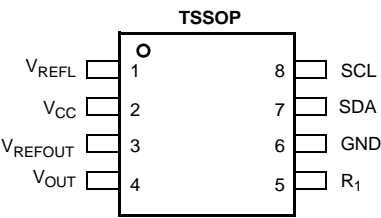


## PIN ASSIGNMENTS

| TSSOP | Symbol | Description |
|---|---|---|
| 1 | $V_{REFL}$ | DCP and auxiliary resistor reference input |
| 2 | $V_{CC}$ | Positive Power Supply |
| 3 | $V_{REFOUT}$ | Bandgap Reference Output |
| 4 | $V_{OUT}$ | DCP Wiper Output |
| 5 | $R_1$ | Auxiliary resistor input |
| 6 | GND | Ground |
| 7 | SDA | Serial Data Input/Output |
| 8 | SCL | Serial Clock Input |

## ABSOLUTE MAXIMUM RATINGS

Supply Voltage Range....................................-1V to 7V
Bias Temperature Range ................... -40°C to +85°C
Storage Temperature Range............ -65°C to +150°C
Voltage on $V_{REF(LOW)}$ pin .............................0V to $V_{CC}$
Voltage on all other pins ................ -0.3V to $V_{CC}$+0.3V
Lead temperature (soldering, 10 seconds)........ 300°C

## RECOMMENDED OPERATING CONDITIONS

|  | **Min** | **Max** |
|---|---|---|
| Temperature | -40°C | +85°C |
| Supply Voltage | 2.7V | 5.5V |

## COMMENTS

Absolute Maximum Ratings indicate limits beyond which permanent damage to the device and impaired reliability may occur. These are stress ratings provided for information only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification are not implied.

For guaranteed specifications and test conditions, see Electrical Characteristics.

The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.

## ELECTRICAL CHARACTERISTICS

(Over operating conditions unless otherwise specified. $I_{OUT}$ = 12.5 µA, $R_1$ = N/C (Floating).)

## ANALOG PARAMETERS

| Symbol | Parameter | Limits | | | Unit | Test Conditions |
|---|---|---|---|---|---|---|
| | | **Min.** | **Typ. [1]** | **Max.** | | |
| **Power Supply** | | | | | | |
| $V_{CC}$ | Supply Voltage Range | 2.7 | 3.0 | 5.5 | V | |
| $I_Q$ | Supply Current<br>$V_{CC}$ = 2.7V<br>$V_{CC}$ = 3V<br>$V_{CC}$ = 5.5V Write | | 15 | 20<br><br>60 | µA | $R_L$=0, $V_{REFL}$, $V_{OUT}$, $R_{AUX}$ = floating |
| $I_{Q(NV)}$ | Non-Volatile Supply Current<br>$V_{CC}$ = 2.7V<br>$V_{CC}$ = 3V<br>$V_{CC}$ = 5.5V | | 600 | 1100<br><br>1300 | µA | $R_L$=0, $V_{REFL}$, $V_{OUT}$, $R_{AUX}$ = floating |
| **Reference Output Voltage** | | | | | | |
| **DC Parameters** | | | | | | |
| $V_{REFOUT}$ | Output Voltage | 1.237 | 1.250 | 1.263 | V | $T_A$ = 25°C |
| $V_{REFL}$ | DCP and auxilliary resistor reference input | GND | | $V_{REFOUT}$ | V | |
| TCOref | Temperature coefficient of $V_{REF}$ output voltage | | 20 | 70 | ppm/°C | [2, 5] |
| PSRR | Power Supply Rejection | 55 | 66 | | dB | [6] |
| $I_{OUT}$ | Output Current<br>Sourcing<br>Sinking | | <br><br>1 | 400 | µA | [2] |
| $R_{OUT}$ | Output Impedance | | 1 | 2.5 | Ω | Given by $R_{OUT} = (\Delta V_{REF}/\Delta I_{OUT})$ [2] |
| $I_{SC}$ | Short Circuit Current<br>Sourcing<br>Sinking | | 5<br>0 | | mA | At 5.5V |
| $C_L$ | Load Capacitance | | 0.001 | 0.003 | µF | Reference output stable for all CL up to specifications [2] |

### ANALOG PARAMETERS (CONTINUED)

| Symbol | Parameter | Min. | Typ. [1] | Max. | Unit | Test Conditions |
|---|---|---|---|---|---|---|
| | | **Limits** | | | | |
| | | Min. | Typ. [1] | Max. | Unit | Test Conditions |
| **AC Parameters** | | | | | | |
| $V_N$ | Output Voltage Noise | | 100 | | µVP-P | 0.1Hz to 10Hz [2] |
| | | | 200 | | µVRMS | 10Hz to 10kHz [2] |
| | Power-on Response | | 250 | | µs | 1% Settling [2] |
| | Line Ripple Rejection | | 60 | | dB | $V_{DD}$ = 3V ±100mV, f = 120 Hz [2] |
| **Reference DCP** | | | | | | |
| | Resolution | | | 8 | bits | |
| $R_{TOT}$ | End to end resistance | 85 | 100 | 115 | kΩ | |
| $R_W$ | Wiper Resistance $V_{CC}$ = 2.7V $V_{CC}$ = 3V | | 600 | 5000 1200 | Ω | [2] |
| | Absolute Linearity (INL) | | ±0.2 | | LSB | |
| | Relative Linearity (DNL) | | ±0.1 | | LSB | |
| | $R_{TOT}$ Temperature Coeff. | | ±300 | | ppm/°C | |
| | Ratiometric Temp. Coeff. | | ±20 | | ppm/°C | |
| **$R_{AUX}$ (Auxiliary Resistor)** | | | | | | |
| $R_{TOT}$ | End to end resistance | 85 | 100 | 115 | kΩ | |
| | $R_{TOT}$ Temperature Coeff. | | ±300 | | ppm/°C | $R_L$=0, $V_{REFL}$, $V_{OUT}$, $R_{AUX}$ = floating |
| | DCP Matching Tolerance | | 0.1 | | % | |
| | DCP Matching Temp. Coeff. | | ±20 | | ppm/°C | |

### DIGITAL PARAMETERS

| Symbol | Parameter | Min. | Typ. [1] | Max. | Unit | Test Conditions |
|---|---|---|---|---|---|---|
| | | **Limits** | | | | |
| | | Min. | Typ. [1] | Max. | Unit | Test Conditions |
| $I_{LI}$ | Input Leakage Current | | | 2 | µA | $V_{IN}$ = GND to $V_{CC}$ |
| $I_{LO}$ | Output Leakage Current | | | 2 | µA | $V_{OUT}$ = GND to $V_{CC}$ |
| $V_{IL}$ | Input Low Voltage | 0 | | $V_{CC}$ x 0.2 | V | |
| $V_{IH}$ | Input High Voltage | $V_{CC}$ x 0.7 | | $V_{CC}$ | V | |
| $C_{IN}$ | Input Capacitance | | 5 | | pF | |
| $V_{OL}$ | Output Low Voltage | 0 | | 10 | %$V_{DD}$ | $I_{OL}$ = 100 µA [2] |
| $V_{OH}$ | Output High Voltage | 90 | | 100 | %$V_{DD}$ | $I_{OH}$ = 100 µA [2] |
| $C_L$ | Output Load | | | 100 | pF | [2] |

### EEPROM PARAMETERS (Erase at $V_{CC}$ = 5.0 V min, T = 25°C)

| Parameter | Min. | Units |
|---|---|---|
| Write Cycle Endurance | 100,000 | Cycles per bit |

### CAPACITANCE

| Symbol | Test | Max. | Units | Test Conditions |
|---|---|---|---|---|
| $C_{IN/OUT}$ | Input/Output capacitance (SDA) | 8 | pF | $V_{OUT}$ = 0V [2] |
| $C_{IN}$ | Input capacitance (SCL) | 6 | pF | $V_{IN}$ = 0V [2] |

## A.C. TEST CONDITIONS

| Input Pulse Levels | $V_{CC}$ x 0.1 to $V_{CC}$ x 0.9 |
|---|---|
| Input rise and fall times | 10ns |
| Input and output timing threshold level | $V_{CC}$ x 0.5 |
| External load at pin SDA | 2.3k$\Omega$ to $V_{CC}$ and 100 pF to $V_{SS}$ |

## AC SPECIFICATIONS

| Symbol | Parameter | Min. | Max. | Unit |
|---|---|---|---|---|
| $f_{SCL}$ | SCL Clock Frequency | 0 | 400 | kHz |
| $t_{IN}$ | Pulse width Suppression Time at inputs [2] | 50 | | ns |
| $t_{AA}$ | SCL LOW to SDA Data Out Valid [2] | 0.1 | 0.9 | µs |
| $t_{BUF}$ | Time the bus must be free before a new transmission can start [2] | 1.3 | | µs |
| $t_{LOW}$ | Clock LOW Time | 1.3 | | µs |
| $t_{HIGH}$ | Clock HIGH Time | 0.6 | | µs |
| $t_{SU:STA}$ | Start Condition Setup Time | 0.6 | | µs |
| $t_{HD:STA}$ | Start Condition Hold Time | 0.6 | | µs |
| $t_{SU:DAT}$ | Data In Setup Time | 100 | | ns |
| $t_{HD:DAT}$ | Data In Hold Time | 0 | | µs |
| $t_{SU:STO}$ | Stop Condition Setup Time [2] | 0.6 | | µs |
| $t_{DH}$ | Data Output Hold Time [2] | 50 | | ns |
| $t_R$ | SDA and SCL Rise Time [2, 3] | 20 +.1Cb | 300 | ns |
| $t_F$ | SDA and SCL Fall Time [2, 3] | 20 +.1Cb | 300 | ns |
| Cb | Capacitive load for each bus line [2, 3] | | 400 | pF |

## TIMING DIAGRAMS

### Bus Timing
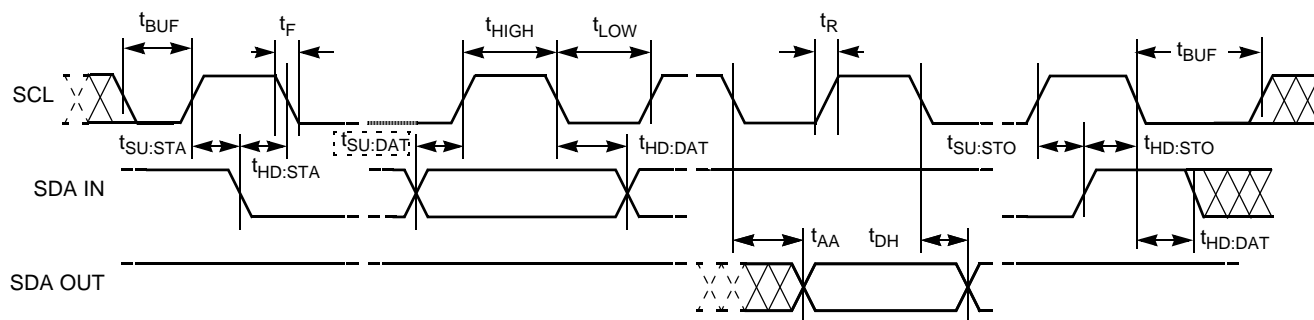
## WRITE CYCLE TIMING
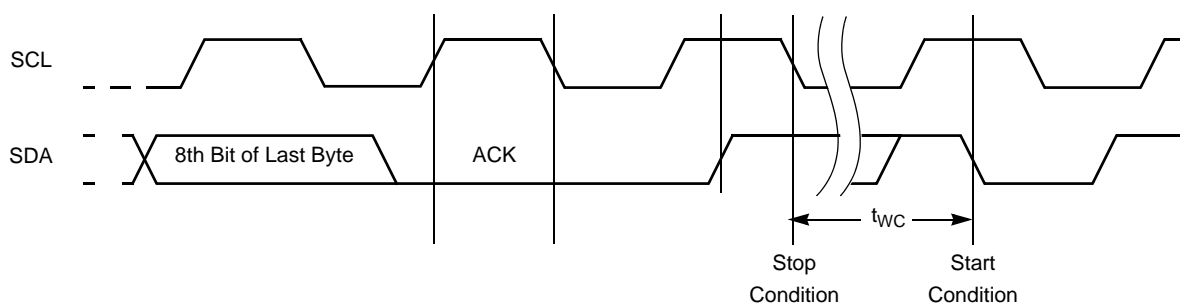


## POWER-UP TIMING

| Symbol | Parameter | Min. | Max. | Unit |
|---|---|---|---|---|
| $\Delta V_{CC}/\Delta t$ | $V_{CC}$ Power-up rate [2] | 0.2 | 50 | V/ms |
| $t_{PUR}$ | Time from Power-up to Read [2] | | 1 | ms |
| $t_{PUW}$ | Time from Power-up to Write [2] | | 5 | ms |

## NONVOLATILE WRITE CYCLE TIMING

| Symbol | Parameter | Min. | Typ. | Max. | Unit |
|---|---|---|---|---|---|
| $t_{WC}$ | Write Cycle Time [4] | | 5 | 10 | ms |

Notes: (1) Typical values are for $T_A = 25°C$ and $V_{CC} = 3.0V$

     (2) This parameter is guaranteed by characterization.

     (3) Cb = total capacitance of one bus line in pF.

     (4) $t_{WC}$ is the time from a valid stop condition at the end of a write sequence to the end of the self-timed internal nonvolatile write cycle. It is the minimum cycle time to be allowed for any nonvolatile write by the user, unless Acknowledge Polling is used.

     (5) Over the specified temperature range. Temperature coefficient is measured by the box method whereby the change in $V_{OUT}$ is divided by the temperature range; in this case, -40°C to +85°C = 125°C. TCOref = [Max V($V_{REF}$) - Min V($V_{REF}$)] $\times$ $10^6$ / (1.25V $\times$ 125°C)

## FUNCTIONAL DESCRIPTION

The X60250 combines a micropower precision reference with an 8-bit, 256 tap digitally controlled 100k$\Omega$ potentiometer (DCP) which allows nonvolatile setting of an output reference voltage. When normally configured with the $V_{REFL}$ pin tied to ground, the device provides an output range of 0V to 1.25V with 4.90mV resolution.

The device can also be configured with an optional 100k$\Omega$ series resistor to ground, which effectively halves the output voltage range while doubling the resolution. Grounding the $R_1$ pin while floating the $V_{REFL}$ pin places the device in this mode. Output voltage setting accuracy can be as high as 0.10% while permitting adjustment from 0.625V to 1.25V (2.45mV resolution).

### Reference Section

The reference is designed to provide an accurate, low tempco voltage source while requiring less than 12µA (typical) of supply current. This supply current is for the reference section only. Keep in mind that the DCP will increase supply current draw by VREF/RTOTAL (typically 1.25/100k or 12.5µA). The total current drawn by the adjustable reference circuit will be less than 25µA (typically).

The reference output has a typical impedance of 1$\Omega$ and can provide up to 400µA of load current. It is intended to drive the resistive load of the DCP, which is a minimum of 85k$\Omega$, but can also be used to drive off chip circuitry provided the loading does not exceed the 400µA maximum. Also, highly capacitive loads can make the reference oscillate, so no more than 2000pF should be placed directly on the output of the $V_{REFOUT}$ pin.

The reference output produces about 200µV RMS of noise (10kHz bandwidth) due to its micropower design. This is easily reduced in normal applications, as shown in the applications section for optimizing circuits for reducing output noise levels.

### DCP Section

The 256 tap DCP has an 8-bit nonvolatile wiper control register which controls which tap is selected. The register is changed by performing a serial data write to its address (0h, see Serial Interface section). The resulting wiper position will produce an output voltage at $V_{OUT}$, depending on whether the DCP $V_{REFL}$ is grounded or the $R_1$ pin is grounded. The wiper consists of CMOS transistors and has a finite resistance, typically 600$\Omega$ at $V_{CC}$ = 5V (this parameter increases with decreasing $V_{CC}$). The wiper resistance will produce errors in reference circuits due to I-R drops if current flows through the wiper. However, typically these circuits will have the wiper connected to a high impedance comparator or amplifier input which results in very small wiper currents and thus only a small output voltage error. If the X60250 is used with the wiper connected to $V_{REFL}$ to produce a current source, care must be taken to avoid exceeding the maximum output current of the reference (typically 400µA).

### Power-Up considerations

The X60250 contains EEPROM nonvolatile storage cells which are recalled during power-up. This recall process works best with power supply ($V_{CC}$) ramping that is monotonic and free of excessive glitches (<100mV disturbances give best results). The ramp rate spec should be adhered to, although the most sensitive part of recall is between $V_{CC}$ = 1.0V and 2.5V. Effort should be made to make sure the device receives a power-up ramp between those voltage levels that meet the ramp rate spec and have no glitches.

Recall of the stored wiper position happens in < 1ms from $V_{CC}$ reaching 2.5V. Note that any excursions of $V_{CC}$ below 2.5V, although temporary, can cause the wiper to be loaded with the midpoint value (80h) until $V_{CC}$ recovers to its normal voltage.

### Register Organization

There are 2 nonvolatile registers and 1 volatile register available for storage and recall via the serial bus. They contain the current wiper position, a general purpose data register and a status register.

The wiper register is nonvolatile and is at address 0h and contains 8 bits, with the 00h setting corresponding to the tap position nearest $V_{REFL}$, and the FFh setting nearest to $V_{REFOUT}$.

The general purpose register is nonvolatile and is at address 1h, and contains 8 bits for use as scratchpad memory or serial number information.

The Status register is volatile and is at address 7h. It has one active bit, D3, which is the WEL bit. This bit must be set to 1 berfore any nonvolatile writes are performed to the other registers. See the register information on the next page.

**X60250 BUS INTERFACE INFORMATION**

**Figure 1. Slave Address, Word Address, and Data Bytes - Write Mode**

| | | | | | | | | |
|---|---|---|---|---|---|---|---|---|
| **Device Identifier** | | | | **Slave Address*** | | | | |
| 0 | 1 | 0 | 1 | 0 | 0 | 0 / 1 | **0** | **Slave Address Byte** Byte 0 |
| A7 | A6 | A5 | A4 | A3 | A2 | A1 | A0 | **Byte Address** Byte 1 |
| D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | **Data Byte** Byte 2 |
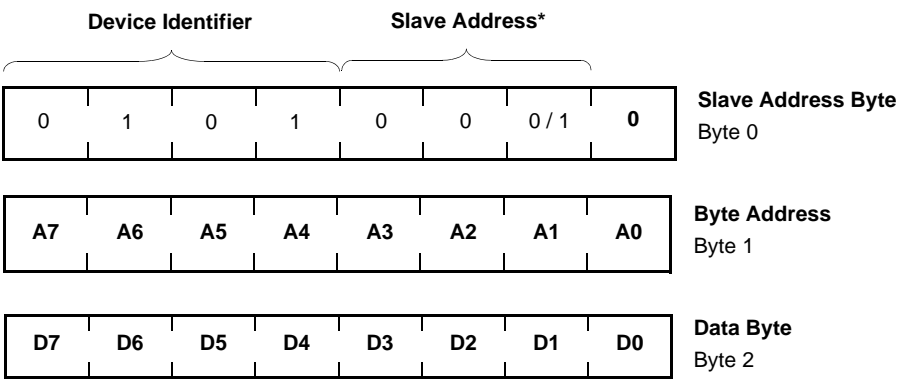
**Figure 2. Slave Address, Word Address, and Data Bytes - Read Mode**

| | | | | | | | | |
|---|---|---|---|---|---|---|---|---|
| **Device Identifier** | | | | **Slave Address*** | | | | |
| 0 | 1 | 0 | 1 | 0 | 0 | 0 / 1 | **1** | **Slave Address Byte** Byte 0 |
| D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | **Data Byte** Byte 1 |
| D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | **Data Byte** Byte 2 |
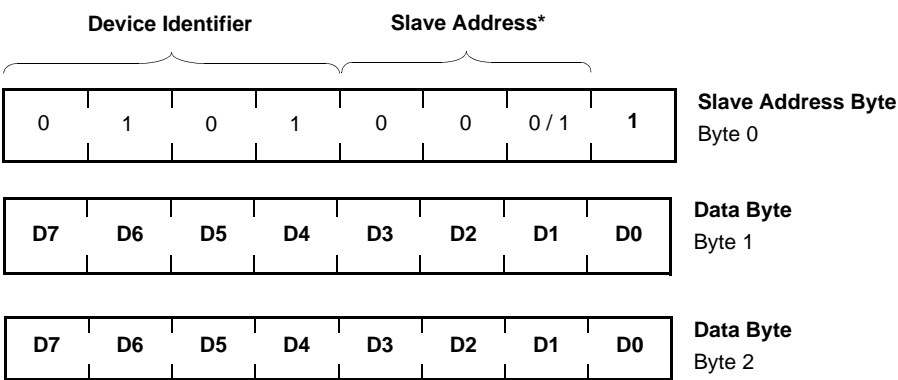
## X60250 BUS INTERFACE INFORMATION

### Slave Address, Address Byte, and Data Byte

The byte communication format for the serial bus is shown in Figure 1 on the previous page. The first byte, BYTE 0, defines the device identifier, 0101 in the upper half; and the device slave address in the low half of the byte. The slave address is set to 0. The next byte, BYTE 1, is the Address Byte. The Address Byte identifies a unique address for the Status or Control Registers as shown in the Register Descriptions table. The following byte, Byte 2, is the byte used for READ and WRITE operations.

### Start Condition

All commands are preceded by the start condition, which is a HIGH to LOW transition of SDA when SCL is HIGH. The device continuously monitors the SDA and SCL lines for the start condition and will not respond to any command until this condition has been met. On power-up, the SCL pin must be brought LOW prior to the START condition. See Figure 3.

### Stop Condition

All communications must be terminated by a stop condition, which is a LOW to HIGH transition of SDA when SCL is HIGH followed by a HIGH to LOW transistion on SCL. After going LOW, SCL can stay LOW or return to HIGH. See Figure 3.

### Acknowledge

Acknowledge is a software convention used to indicate successful data transfer. The transmitting device, either master or slave, will release the bus after transmitting eight bits. During the ninth clock cycle, the receiver will pull the SDA line LOW to acknowledge that it received the eight bits of data. Refer to Figure 4. The device will respond with an acknowledge after recognition of a start condition and if the correct Device Identifier and Select bits are contained in the Slave Address Byte. If a write operation is selected, the device will respond with an acknowledge after the receipt of each subsequent eight bit word. The device will acknowledge all incoming data and address bytes, except for:

– The Slave Address Byte when the Device Identifier and/or Select bits are incorrect

– The 2nd Data Byte of a Status Register Write Operation (only 1 data byte is allowed)

## Pin Descriptions

### $V_{REFOUT}$

Reference voltage output. The 1.25V bandgap reference output ($V_{REF}$) is available at this pin for application to other circuits. Maximum output current is 400µA. The $V_{REFOUT}$ pin also connects to the Rh terminal of the 256-tap DCP.

### $V_{OUT}$

DCP Wiper Output. This pin functions as the wiper of the DCP, and can be used as a variable voltage source for voltages between GND and $V_{REF}$. Since it is connected to the DCP resistor, any loads on this pin must be high impedance for best performance.

### $R_1$

Auxiliary Resistor Input. The $R_1$ pin is connected to one end of a 100kΩ resistor ($R_1$) which closely matches the DCP resistance. The other end of $R_1$ is tied to the $R_{REFL}$ terminal of the DCP. When $R_1$ is grounded and $V_{REFL}$ is left open, the output voltage range of $V_{OUT}$ will be from $V_{REF}/2$ to $V_{REF}$, and the effective resolution (mV/step) of the Reference control is doubled. $R_1$ should be left open if not used.

### GND

This pin is common for the $V_{REF}$ output and for control signal inputs.

### SDA

Serial Data Input/Output. Bidirectional pin used for serial data transfer. As an output, it is open drain and may be wire-ored with any number of open drain or open collector outputs. A pullup resistor is required and the value is dependent on the speed of the serial data bus and the number of outputs tied together.

### SCL

Serial Clock Input. Accepts a clock signal for clocking serial data into and out of the device.

### $V_{REFL}$

DCP and Auxiliary Resistor Input. This pin is connected to one end of the 256-tap DCP, and also to one end of the 100kΩ auxiliary resistor. When connected to ground, $V_{OUT}$ range will be from 0V to $V_{REF}$. When left open and $R_1$ is connected to ground, the voltage at this pin will be from $V_{REF}/2$ to $V_{REF}$.

## $V_{CC}$

Positive Power Supply. Connect to a voltage supply in the range of $2.7V < V_{CC} < 5.5V$, with minimum noise and ripple. For best performance, bypass with a 0.1µF capacitor to ground.
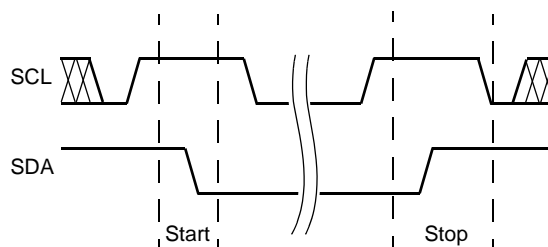
**Figure 3. Valid Start and Stop Conditions**



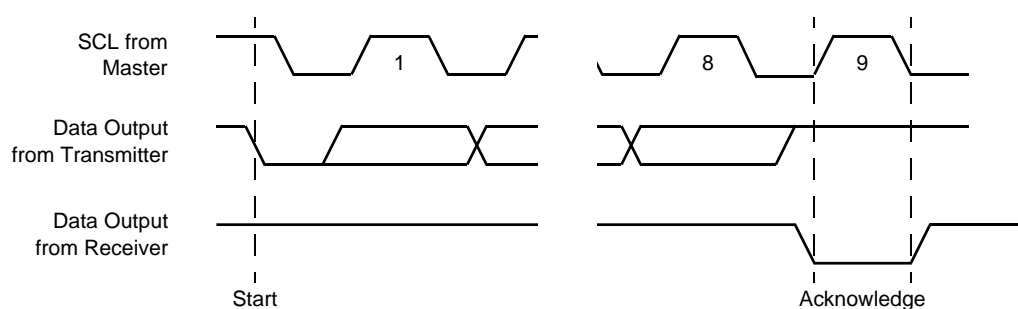**Figure 4. Acknowledge Response From Receiver**
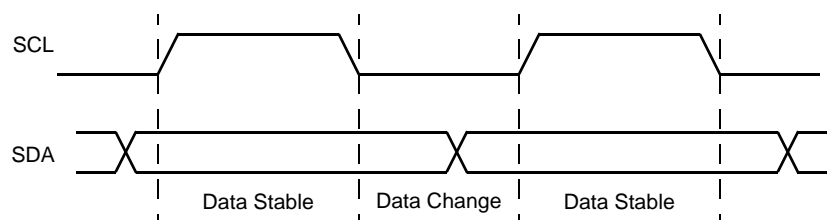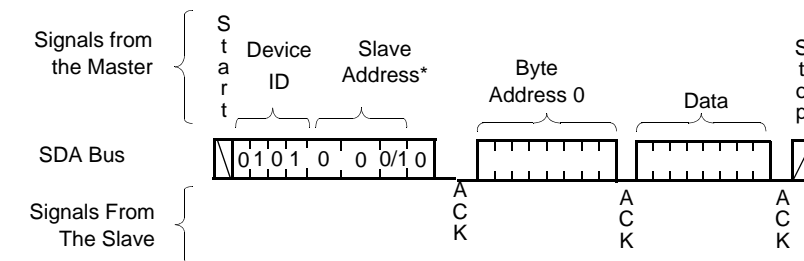


**Figure 5. Valid Data Changes on the SDA Bus**

**Figure 6. Byte Write Sequence**



**\*Note:** The X60250 will respond to either 000 or 001 slave addresses.

**Byte Write**

For a write operation, the device requires the Slave Address Byte and the Word Address Bytes. This gives the master access to any one of the words in the array. Upon receipt of each address byte, the X60250 responds with an acknowledge. After receiving the address bytes the X60250 awaits the eight bits of data. After receiving the 8 data bits, the X60250 again responds with an acknowledge. The master then terminates the transfer by generating a stop condition. The X60250 then begins an internal write cycle of the data to the nonvolatile memory. During the internal write cycle, the device inputs are disabled, so the device will not respond to any requests from the master. The SDA output is at high impedance. See Figure 6.

A write to a protected block of memory is ignored, but will still receive an acknowledge. At the end of the write command, the X60250 will not initiate an internal write cycle, and will continue to okay commands.

**Stops and Write Modes**

Stop conditions that terminate write operations must be sent by the master after sending at least 1 full data byte and its associated ACK signal. If a stop is issued in the middle of a data byte, or before 1 full data byte + ACK is sent, then the X60250 resets itself without performing the write. The contents of the array are not affected.

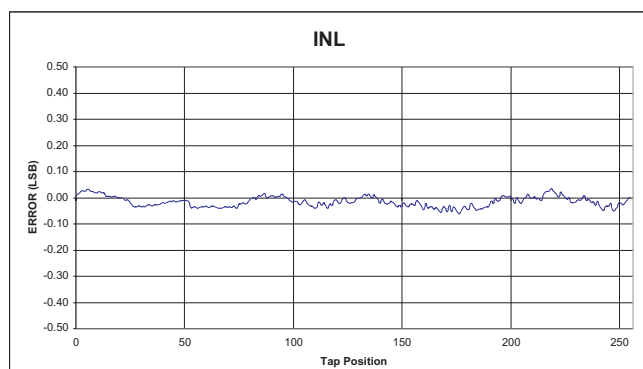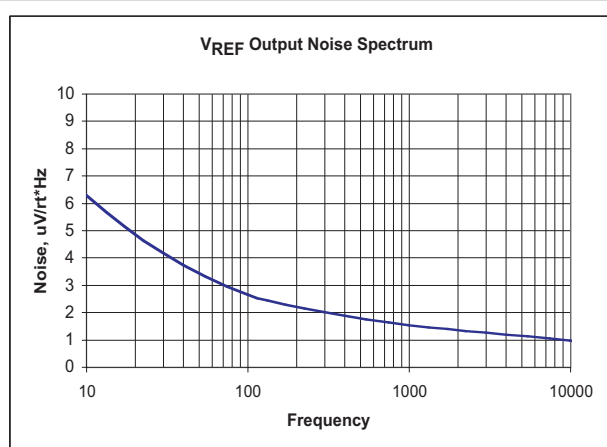**Figure 7. Random Address Read Sequence**
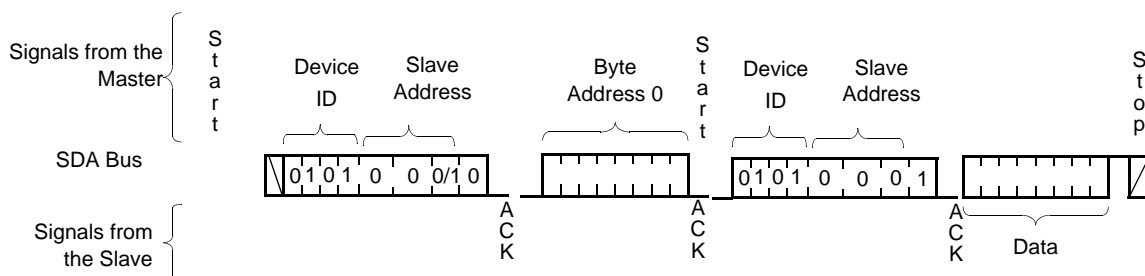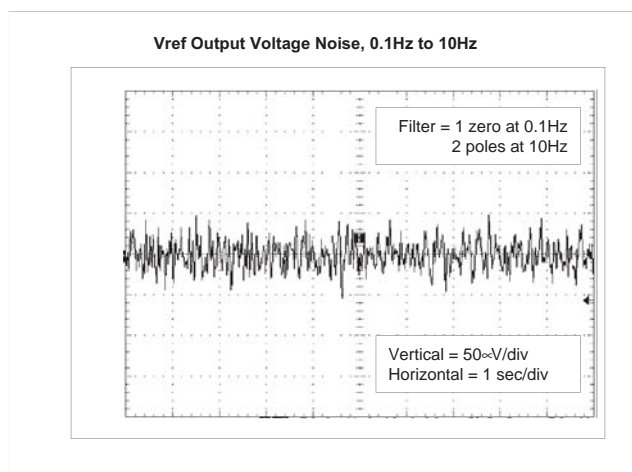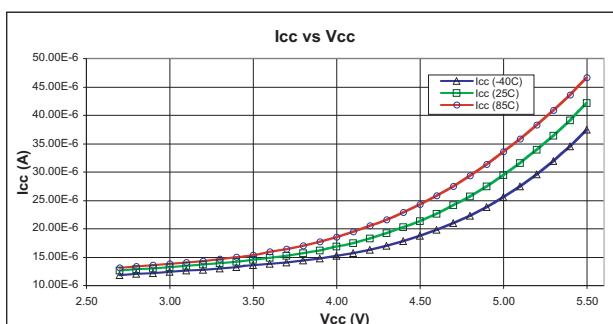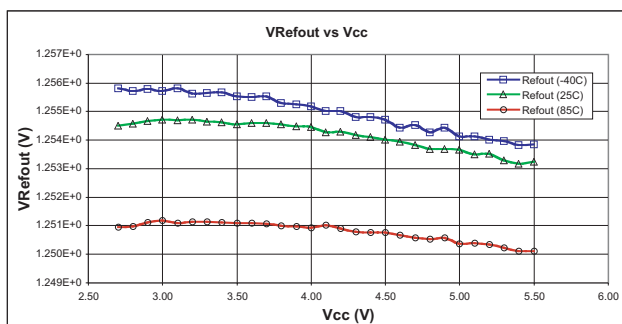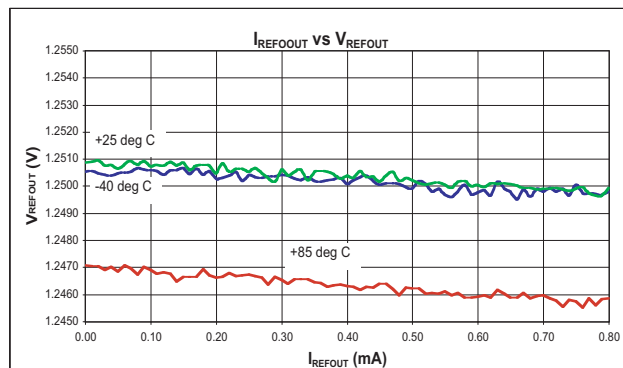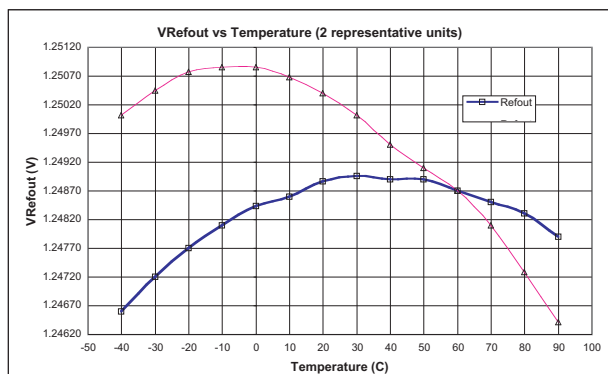


**Random Address Read**

Random read operation allows the master to access any location in the X60250. Prior to issuing the Slave Address Byte, the master must first perform a "dummy" write operation.

The master issues the start condition and the slave address byte, receives an acknowledge, then issues the word address bytes. After acknowledging receipt of each word address byte, the master immediately issues another start condition and the slave address byte. This is followed by an acknowledge from the device and then by the eight bit data word. The master terminates the read operation by not responding with an acknowledge and then issuing a stop condition. Refer to Figure 7 for the address, acknowledge, and data transfer sequence.
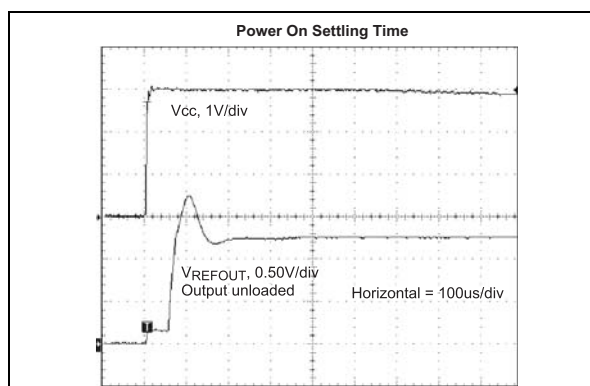
In a similar operation called "Set Current Address," the device sets the address if a stop is issued instead of the second start shown in Figure 7. The X60250 then goes into standby mode after the stop and all bus activity will be ignored until a start is detected. This operation loads the new address into the address counter. The next Current Address Read operation will read from the newly loaded address. This operation could be useful if the master knows the next address it needs to read, but is not ready for the data.

# X60250

## TYPICAL PERFORMANCE CHARACTERISTIC CURVES



VRefout vs Temperature (2 representative units)



$I_{REFOOUT}$ vs $V_{REFOUT}$



VRefout vs Vcc



Icc vs Vcc



Vref Output Voltage Noise, 0.1Hz to 10Hz



$V_{REF}$ Output Noise Spectrum



INL



DNL
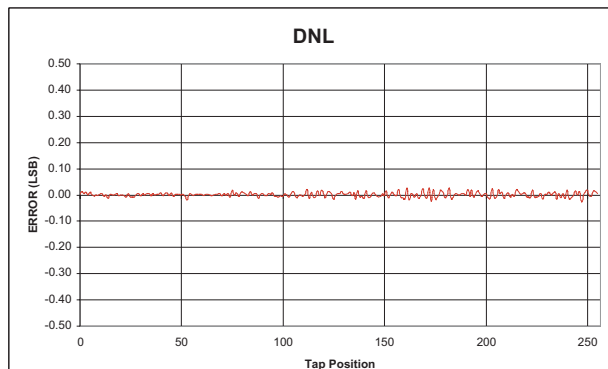
## TYPICAL PERFORMANCE CHARACTERISTIC CURVES (Continued)

**Power On Settling Time**

Vcc, 1V/div

$V_{REFOUT}$, 0.50V/div
Output unloaded

Horizontal = 100us/div

## APPLICATIONS INFORMATION

### Standard Reference configurations

Figure 8 shows the device connections to produce a 0 to 1.250V adjustable reference with 8 bits of resolution. $V_{REFL}$ will be grounded in this case. Figure 9 has device connections to produce a 0.625V to 1.250V reference with 8 bits of resolution, with $R_1$ grounded. This configuration effectively doubles the output voltage control resolution, increasing the accuracy of the desired reference output voltage. Since the auxiliary resistor is matched to the DCP resistor, temperature drift is minimized.
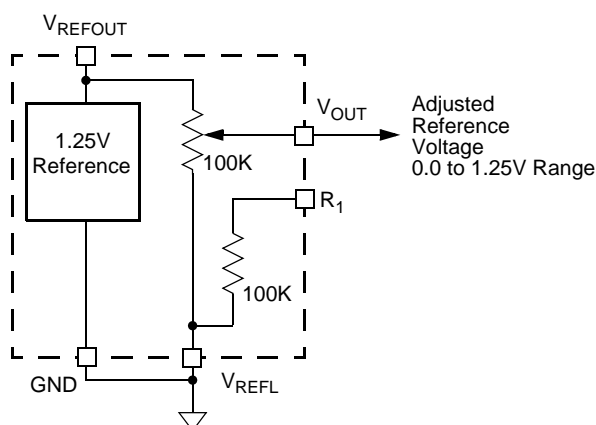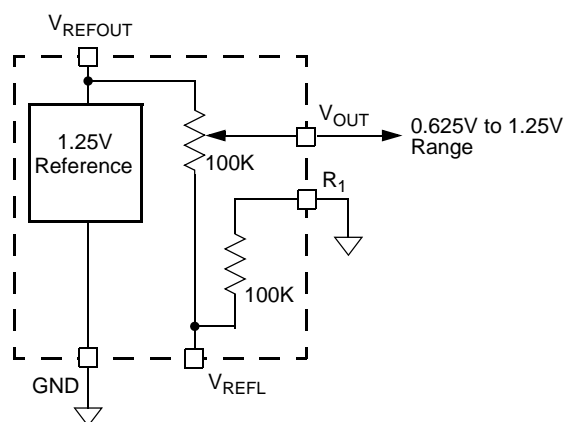
### Figure 8. Standard Configuration

V$_{REFOUT}$

1.25V
Reference

V$_{OUT}$

Adjusted
Reference
Voltage
0.0 to 1.25V Range

100K

$R_1$

100K

GND

V$_{REFL}$

### Figure 9. Using Auxilliary Resistor

V$_{REFOUT}$

1.25V
Reference

V$_{OUT}$

0.625V to 1.25V
Range

100K

$R_1$

100K

GND

V$_{REFL}$

### Reducing Output Noise

The output noise voltage of the reference is typically 200μV rms in the 10kHz bandwidth. An advantage of the adjustable reference configuration is the ease in filtering this noise. Simply adding a capacitor to the $V_{OUT}$ pin will produce a single pole filter with a corner frequency of:

$$F_{CORNER} = \frac{1}{2} \times \pi \times R_{DCP} \times C_{FILTER}$$

$R_{DCP}$ will vary with tap position and wiper resistance. If the approximate tap position of the DCP is known, it can be used to calculate this resistance as follows:

$$R_{DCP} = \frac{255 - tap\#}{255} \times \left[ R_{TOTAL} \| \left( \frac{tap\#}{255} \times R_{TOTAL} \right) \right] + R_{WIPER}$$

For example, with $V_{CC}$ = 5V, tap # = 127 (corresponding to $V_{OUT}$ = 0.623V), $C_{FILTER}$ = 0.1μF, using typical values:

$$R_{DCP} = 25K + 0.6K = 25.6k\Omega$$
$$F_{CORNER} = 62Hz$$

Since this is a single pole rolloff, the actual noise bandwidth is 1.57 times this, or 97Hz. This should reduce typical output noise to about 45μV rms. Note that if the wiper is set to the highest tap positon (tap# = 255) to give a $V_{OUT}$ of 1.25V, the resulting $R_{DCP} = R_{WIPER}$ or 600Ω, and the filter bandwidth will now be 2.6kHz, increasing noise significantly. If tap positions near $V_{REFOUT}$ will be used, then a series resistor $R_{OUT}$ should be added to better control noise bandwidth.
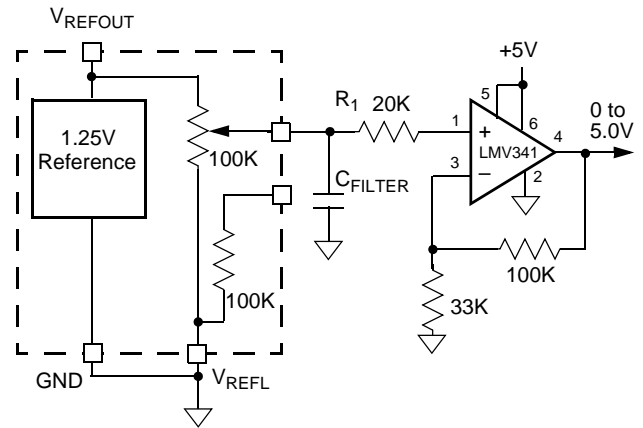
### Figure 10. Reducing Output Noise
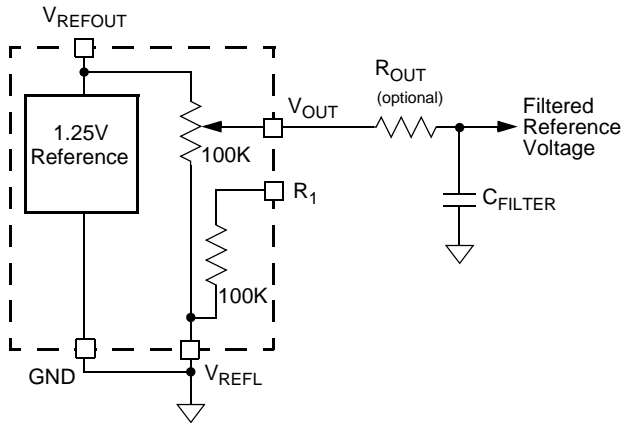


**Higher Reference Voltages**

If a reference voltage higher than 1.25V is required, then an opamp can be added to amplify the $V_{OUT}$ voltage. There are many micropower opamps available, such as the LMV341, which can produce an output at very close to either supply rail. Figure 11 shows a circuit for a 0V to 5.0V adjustable reference, which has 8 bits of control. Note that if the auxiliary resistor is connected to ground instead of $V_{REFL}$, then the output voltage range will be 2.5V to 5.0V, but resolution will double. Total current draw from that circuit will be 156μA (typically, with $V_{OUT} = 5V$) including reference and opamp circuitry. Note that due to $V_{CC}$ supply variations, the output may not span up to 5.00V which would result in missing codes at the top end of the DCP range.
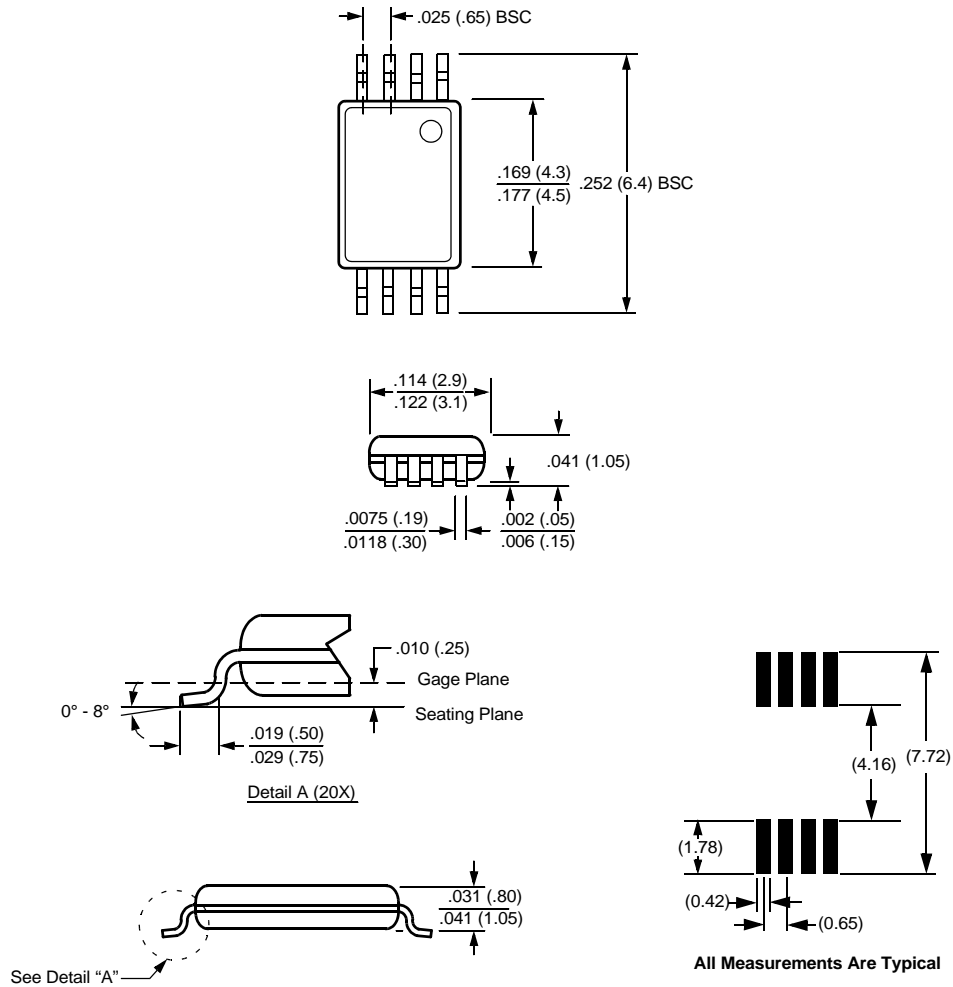
### Figure 11. Increasing Reference Output Voltage

## PACKAGING INFORMATION

### 8-Lead Plastic, TSSOP, Package Code V8

.025 (.65) BSC

.169 (4.3) / .177 (4.5)

.252 (6.4) BSC

.114 (2.9) / .122 (3.1)

.041 (1.05)

.0075 (.19) / .0118 (.30)

.002 (.05) / .006 (.15)

.010 (.25)

Gage Plane

Seating Plane

0° - 8°

.019 (.50) / .029 (.75)

Detail A (20X)

(4.16)   (7.72)

(1.78)

(0.42)

(0.65)

.031 (.80) / .041 (1.05)

See Detail "A"

**All Measurements Are Typical**

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